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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/047,627	01/14/2002	Satoshi Yamamoto	113197-020	4034	
24573 7	590 07/10/2003				
BELL, BOYD & LLOYD, LLC			EXAMINER		
PO BOX 1135 CHICAGO, IL 60690-1135			FERGUSON, MARISSA L		
			ART UNIT	PAPER NUMBER	
			2854		
			DATE MAILED: 07/10/2003		

Please find below and/or attached an Office communication concerning this application or proceeding.

				_	_ 11 /				
-	,1	Application No).	plicant(s)					
Offic Action Summary		10/047,627		YAMAMOTO ET A	L.				
		Examiner		Art Unit					
		Marissa L Ferg		2854					
The MAILING DATE f this communication app ars on the cover sheet with the correspondence address Period f r Reply									
A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely. - If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication. - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). - Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b). Status									
1)⊠	Responsive to communication(s) filed on 14	<u> April 2003</u> .							
2a) <u></u>	This action is FINAL. 2b)⊠ Th	nis action is non-	final.						
3)□	3) Since this application is in condition for allowance except for formal matters, prosecution as to the ments is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.								
•	on of Claims								
	Claim(s) 1-7 is/are pending in the application								
4a) Of the above claim(s) 2.3.5-7 is/are withdrawn from consideration.									
5)□	Claim(s) is/are allowed.								
6)⊠	Claim(s) <u>1 and 4</u> is/are rejected.								
7) Claim(s) is/are objected to.									
	Claim(s) are subject to restriction and/o	or election requi	rement.						
	on Papers								
	The specification is objected to by the Examine			h. the Everiner					
10) ☐ The drawing(s) filed on 14 January 2002 is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.									
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).									
11) The proposed drawing correction filed on is: a) approved b) disapproved by the Examiner.									
If approved, corrected drawings are required in reply to this Office action.									
12) The oath or declaration is objected to by the Examiner.									
Priority under 35 U.S.C. §§ 119 and 120									
13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).									
a)	⊠ All b) Some * c) None of:								
	1. Certified copies of the priority documen			iau Na					
	2. Certified copies of the priority documen				2				
 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 									
14) 🗌 A	Acknowledgment is made of a claim for domes	tic priority under	35 U.S.C. § 119(e) (to a provisiona	l application).				
a) ☐ The translation of the foreign language provisional application has been received. 15)☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.									
Attachmen	nt(s)	_							
2) Notice	ce of References Cited (PTO-892) ce of Draftsperson's Patent Drawing Review (PTO-948) mation Disclosure Statement(s) (PTO-1449) Paper No(s)	4) [5) [6) [Notice of Informal	y (PTO-413) Paper No Patent Application (PT					
U.S. Patent and 1	Frademark Office			Port of Paper No. 8					



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DETAILED ACTION

Drawings

1. The drawings are objected to under 37 CFR 1.83(a). The drawings must show every feature of the invention specified in the claims. Therefore, the etch pit on the top face of the diaphragm must be shown or the feature(s) canceled from the claim(s). No new matter should be entered.

A proposed drawing correction or corrected drawings are required in reply to the Office action to avoid abandonment of the application. The objection to the drawings will not be held in abeyance.

Claim Rejections - 35 USC § 103

- 2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1 and 4 are rejected under 35 U.S.C. 103(a) as being unpatentable over Ko (US Patent 5,528,452) in view of Sidner et al. (US 4,993,143).

Ko teaches a pressure sensor comprising a silicon structure having a conductive diaphragm (3), a silicon substrate bonded on a substrate, which comprises an electrode covered by a dielectric film (2), so that a diaphragm and an electrode are facing each other and there is a gap between a diaphragm and a dielectric film, a pressure sensor measuring a pressure applied thereto by detecting capacitance according to an area of a contact face of a diaphragm which touches a dielectric film when a pressure is applied

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and a silicon structure having a conductive diaphragm, provided by doping of an impurity and anisotropic etching (Admitted Disclosure of Description of Related Art, Page 1 and Page 2). However, he does not explicitly disclose a concentration of an impurity at a top face of a diaphragm being equal to or greater than $1 \times 10^{19} \, \text{cm}^{-3}$ and less than $9 \times 10^{19} \, \text{cm}^{-3}$ and an etch pit density on a top face of a diaphragm being equal to or less than five per μm^2 .

Sidner et al. teaches a diaphragm portion containing an impurity concentration (Column 3, Lines 40-42) and an etch pit (see elements 16, 28 and 32) density (Column 3, Lines 29-32, Column 4, Lines 40-44 and Column 5, Lines 17-33) that is used to insure adequate thickness of the diaphragm portion. It would obvious at the time the invention was made to a person having ordinary skill in the art to modify the invention as taught by Ko to include impurities and an etch pit as taught by Sidner, since Sidner teaches adding impurities in order to have an improved impurity concentration and an etch pit.

Sidner does not explicitly disclose the specific range or value as claimed, however it would have been obvious to one having ordinary skill in the art at the time the invention was made to provide a specific range or value, since it has been held that where the general conditions of a claim are disclosed in the prior art, discovering the optimum or workable ranges involves only routine skill in the art. *In re Aller*, 105 USPQ 233.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Marissa L Ferguson whose telephone number is (703)

305-3194. The examiner can normally be reached on (M-T) 6:30am-4:00pm and every other (F) 7:30am-4:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Andrew Hirshfeld can be reached on (703) 305-6619. The fax phone numbers for the organization where this application or proceeding is assigned are (703) 308-7722 for regular communications and (703) 308-7722 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-1782.

Marissa L Ferguson Examiner Art Unit 2854

June 30, 2003

ANDREW H. HIRSHFELD SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800